GENERAL SEMICONDUCTOR®

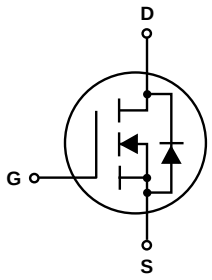
GFD50N03

N-Channel Enhancement-Mode MOSFET

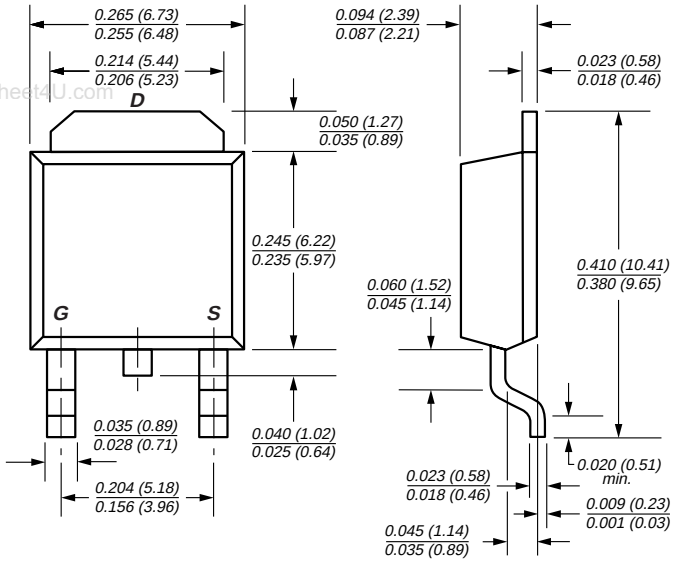
V_{DS} 30V $R_{DS(ON)}$ 9mΩ I_D 65A

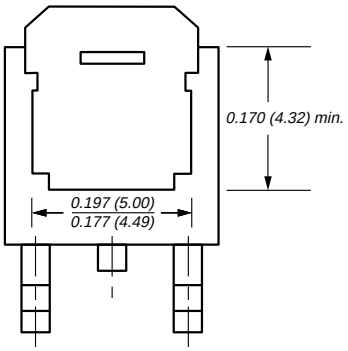
TRENCH GENFET®

New Product

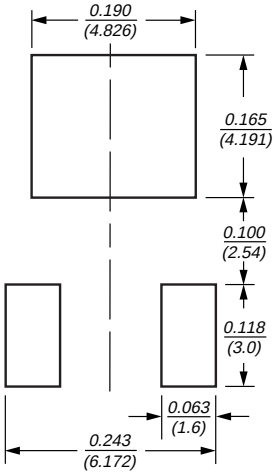


TO-252 (DPAK)





Dimensions in inches and (millimeters)



Mounting Pad Layout

Mechanical Data

Case: JEDEC TO-252 molded plastic body

Terminals: Solder plated, solderable per MIL-STD-750, Method 2026

High temperature soldering guaranteed: 250°C/10 seconds at terminals

Weight: 0.011oz., 0.4g

Features

- Advanced Trench Process Technology
- High Density Cell Design for Ultra Low On-Resistance
- Specially Designed for Low Voltage DC/DC Converters and motor drives
- Fast Switching for High Efficiency

Maximum Ratings and Thermal Characteristics (T_C = 25°C unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	±20	
Continuous Drain Current(1)		I_D	65	A
Pulsed Drain Current		I_{DM}	150	
Maximum Power Dissipation	T_C = 25°C T_C = 100°C	P_D	62.5 25.0	W
Operating Junction and Storage Temperature Range		T_J, T_{stg}	–55 to 150	°C
Junction-to-Case Thermal Resistance		$R_{\theta JC}$	2.0	°C/W
Junction-to-Ambient Thermal Resistance(2)		$R_{\theta JA}$	40	°C/W

Notes: (1) Maximum DC current limited by the package.
(2) 1-in^2 2oz. Cu PCB mounted

5/29/01

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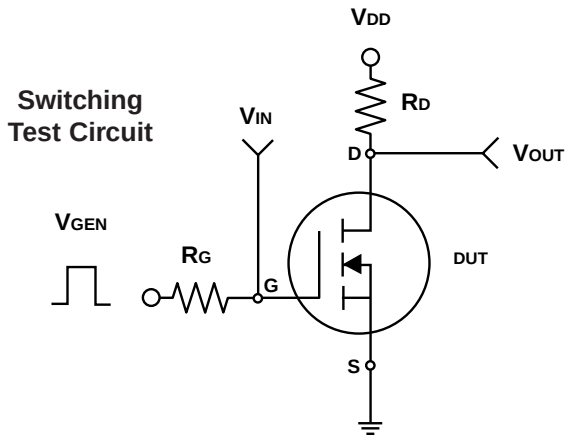
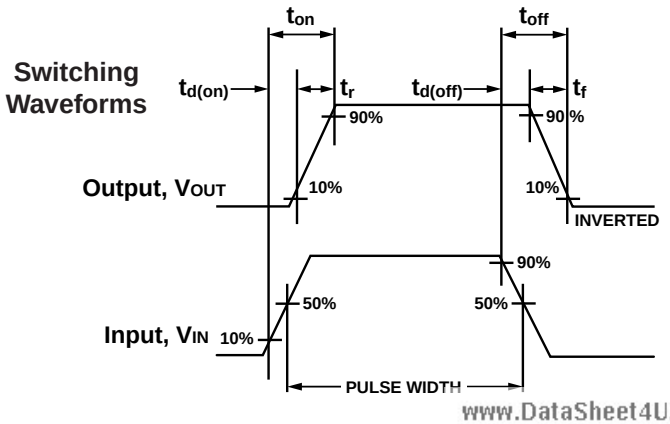
Electrical Characteristics (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS} = 0V, I_D = 250µA	30	—	—	V
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250µA	1.0	—	3.0	V
Gate-Body Leakage	I_{GSS}	V_{DS} = 0V, V_{GS} = ±20V	—	—	±100	nA
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 30V, V_{GS} = 0V	—	—	1.0	µA
On-State Drain Current[1]	$I_{D(on)}$	V_{DS} ≥ 5V, V_{GS} = 10V	50	—	—	A
Drain-Source On-State Resistance[1]	$R_{DS(on)}$	V_{GS} = 10V, I_D = 15A	—	7.1	9	mΩ
		V_{GS} = 4.5V, I_D = 13A	—	10	12	
Forward Transconductance[1]	g_{fs}	V_{DS} = 15V, I_D = 15A	—	50	—	S
Dynamic						
Total Gate Charge	Q_g	V_{DS}=15V, V_{GS}=5V, I_D=15A	—	31	43	nC
		V_{DS} = 15V, V_{GS} = 10V, I_D = 15A	—	60	84	
Gate-Source Charge	Q_{gs}		—	9	—	
Gate-Drain Charge	Q_{gd}		—	8.5	—	
Turn-On Delay Time	$t_{d(on)}$	V_{DD} = 15V, R_L = 15Ω, I_D ≅ 1A, V_{GEN} = 10V, R_G = 6Ω	—	13	26	ns
Rise Time	t_r		—	16	29	
Turn-Off Delay Time	$t_{d(off)}$		—	94	132	
Fall Time	t_f		—	38	57	
Input Capacitance	C_{iss}	V_{GS} = 0V, V_{DS} = 15V, f = 1.0MHz	—	3240	—	pF
Output Capacitance	C_{oss}		—	625	—	
Reverse Transfer Capacitance	C_{rss}		—	285	—	
Source-Drain Diode						
Max Diode Forward Current	I_S	—	—	—	20	A
Diode Forward Voltage[1]	V_{SD}	I_S = 20A, V_{GS} = 0V	—	0.85	1.3	V

Note: (1) Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2%





N-Channel Enhancement-Mode MOSFET

Ratings and Characteristic Curves (TA = 25°C unless otherwise noted)

Fig. 1 – Output Characteristics

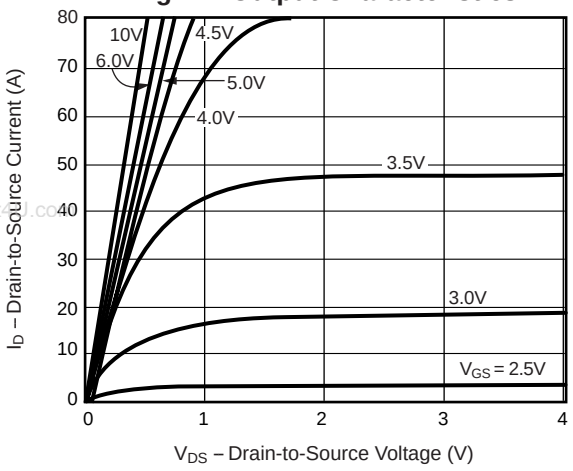


Fig. 2 – Transfer Characteristics

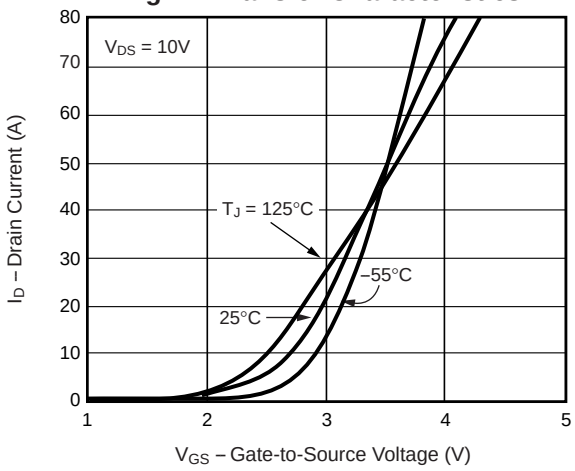


Fig. 3 – Threshold Voltage

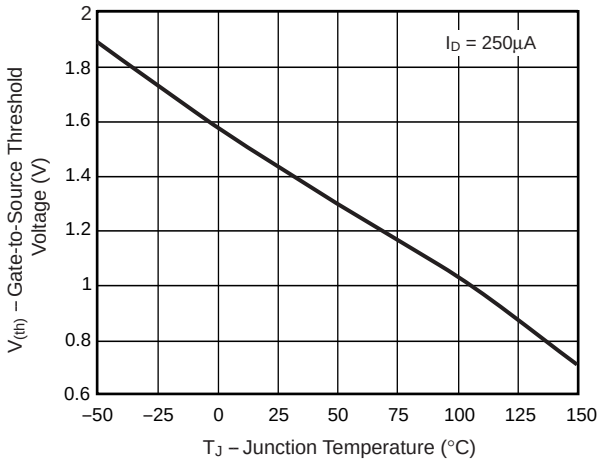


Fig. 4 – On-Resistance vs. Drain Current

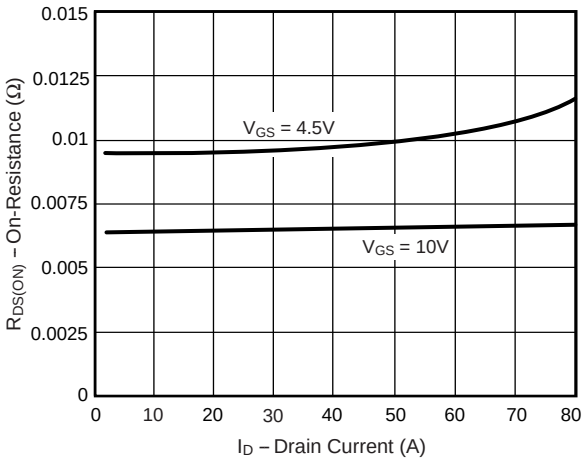


Fig. 5 – On-Resistance vs. Junction Temperature

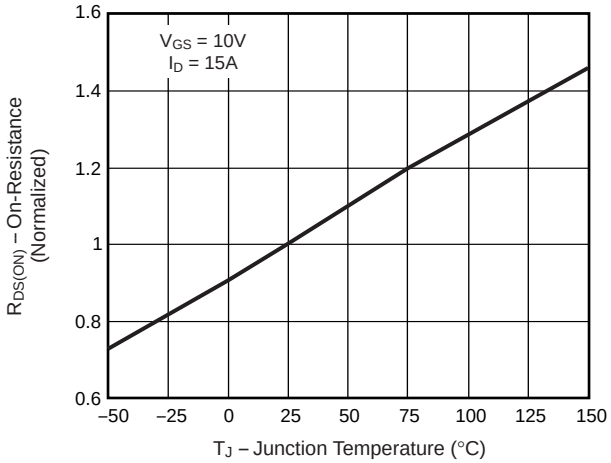


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Fig. 6 – On-Resistance vs. Gate-to-Source Voltage

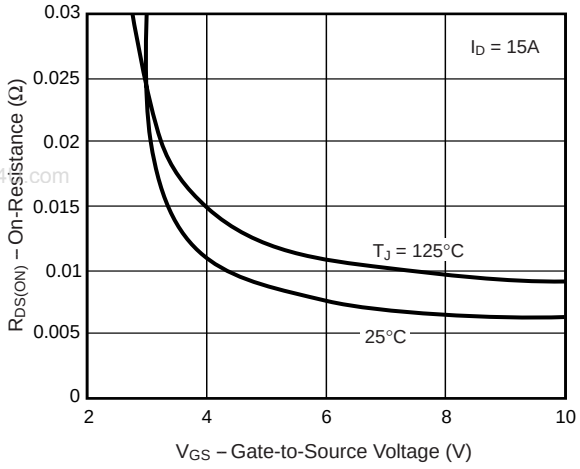

Fig. 7 – Gate Charge

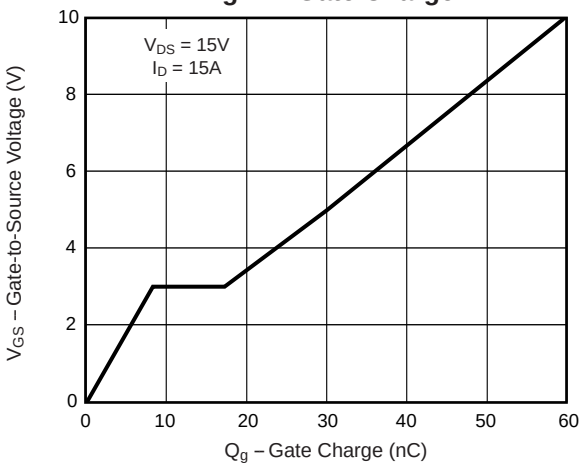

Fig. 8 – Capacitance

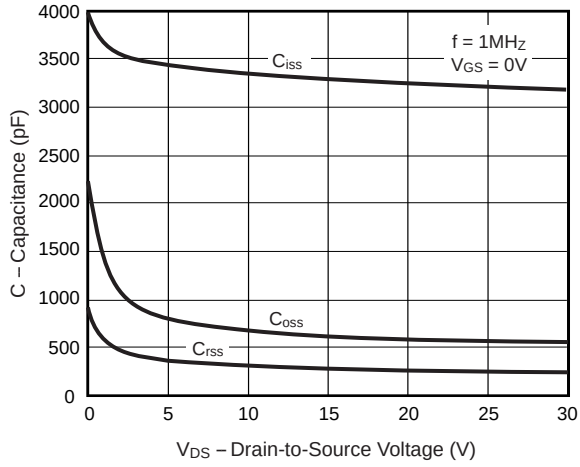

Fig. 9 – Source-Drain Diode Forward Voltage

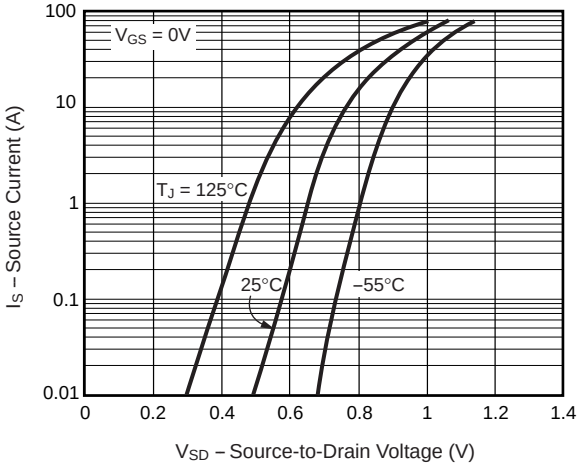

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Fig. 10 – Breakdown Voltage vs. Junction Temperature

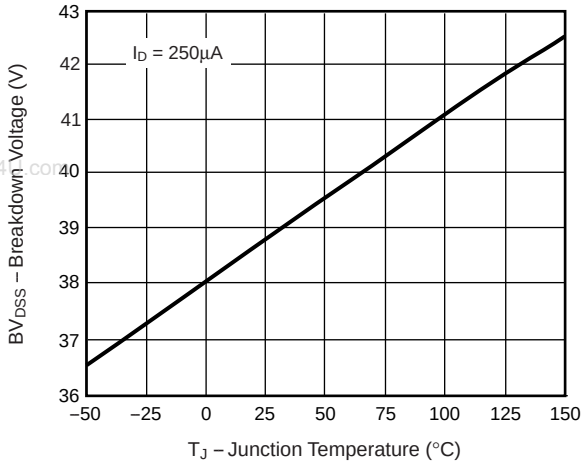

Fig. 11 – Transient Thermal Impedance

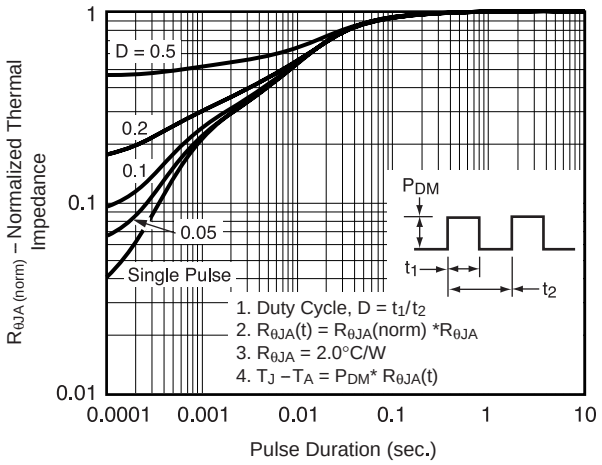

Fig. 12 – Power vs. Pulse Duration

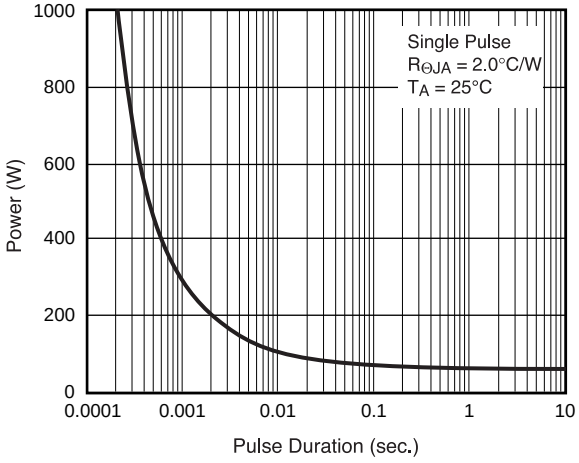

Fig. 13 – Maximum Safe Operating Area